TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π -MOSIII)

2SK2613

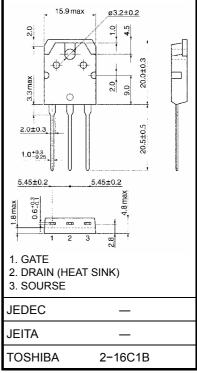
Switching Regulator Applications, DC-DC Converter and Motor Drive Applications

- Low drain-source ON resistance: RDS (ON) = 1.4Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 6.0 \text{ S (typ.)}$
- Low leakage current: $I_{DSS} = 100 \mu A \text{ (max) (V}_{DS} = 800 \text{ V)}$
- Enhancement-model: $V_{th} = 2.0 \sim 4.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteristics			Symbol	Rating	Unit	
Drain-source voltage			V_{DSS}	1000	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)			V_{DGR}	1000	V	
Gate-source voltage			V _{GSS}	±30	V	
Drain current	DC	(Note 1)	I _D	8	Α	
	Pulse	(Note 1)	I _{DP}	24	A	
Drain power dissipation (Tc = 25°C)			P _D	150	W	
Single pulse avalanche energy (Note 2)			E _{AS}	910	mJ	
Avalanche current			I _{AR}	8	Α	
Repetitive avalanche energy (Note 3)			E _{AR}	15	mJ	
Channel temperature			T _{ch}	150	°C	
Storage temperature range			T _{stg}	-55~150	°C	

Unit: mm

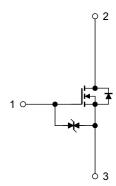


Weight: 4.6 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	0.833	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	50	°C/W



- Note 1: Please use devices on condition that the channel temperature is below 150°C.
- Note 2: $V_{DD} = 90 \text{ V}$, $T_{ch} = 25^{\circ}\text{C}$, L = 26.3 mH, $R_G = 25 \Omega$, $I_{AR} = 8 \text{ A}$
- Note 3: Repetitive rating: Pulse width limited by max junction temperature

This transistor is an electrostatic sensitive device. Please handle with caution.



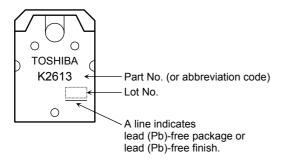
Electrical Characteristics (Ta = 25°C)

Chara	octeristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА
Drain-source brea	akdown voltage	V (BR) GSS	$I_G = \pm 10 \ \mu A, \ V_{DS} = 0 \ V$	±30	_	_	V
Drain cut-OFF cu	Orain cut-OFF current		V _{DS} = 800 V, V _{GS} = 0 V	_	_	100	μА
Drain-source brea	Orain-source breakdown voltage		$I_D = 10$ mA, $V_{GS} = 0$ V	1000	_	_	V
Gate threshold voltage		V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source ON resistance		R _{DS} (ON)	V _{GS} = 10 V, I _D = 4 A	_	1.4	1.7	Ω
Forward transfer admittance		Y _{fs}	V _{DS} = 20 V, I _D = 4 A	2.0	6.0	_	S
Input capacitance		C _{iss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz	_	2000	_	pF
Reverse transfer capacitance		C _{rss}		_	30	_	
Output capacitance		Coss		_	200	_	
Switching time	Rise time	t _r	$V_{GS}^{10 \text{ V}} V_{GS}^{10 \text{ V}} = 4 \text{ A} OV_{OUT}$ $V_{GS}^{CI} \times A OV_{OUT}$ $V_{GS}^{CI} \times A OV_{OUT}$	_	20		ns
	Turn-ON time	t _{on}		_	40	_	
	Fall time	t _f			30		
	Turn-OFF time	t _{off}	Duty \leq 1%, t_W = 10 μs $V_{DD} \simeq$ 400 V	_	100	_	
Total gate charge (gate-source plus gate-drain)		Qg			65	_	nC
Gate-source charge		Q _{gs}	$V_{DD} \simeq 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 8 \text{ A}$	_	40		
Gate-drain ("miller") charge		Q _{gd}		_	25	_	

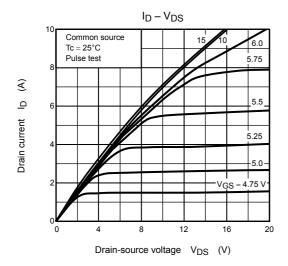
Source-Drain Ratings and Characteristics (Ta = 25°C)

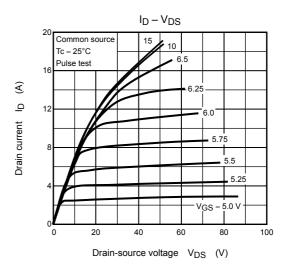
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I_{DR}	_	_	_	8	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	24	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 8 A, V _{GS} = 0 V	_	_	-1.9	V
Reverse recovery time	t _{rr}	I _{DR} = 8 A, V _{GS} = 0 V,	_	1600	_	ns
Reverse recovery charge	Q _{rr}	dI _{DR} /dt = 100 A/μs		24	_	μС

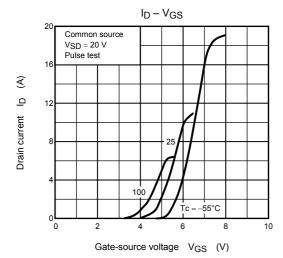
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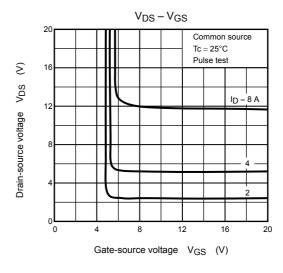


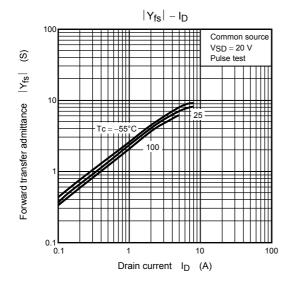
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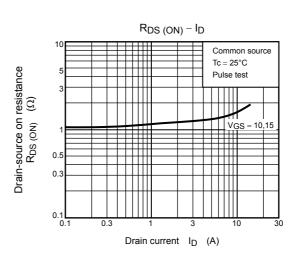


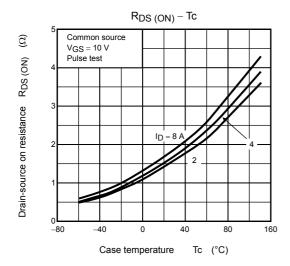


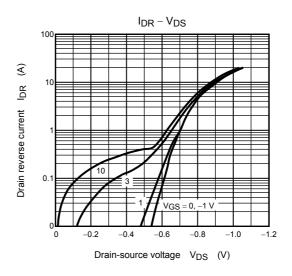


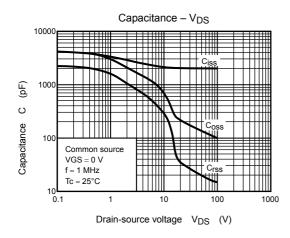


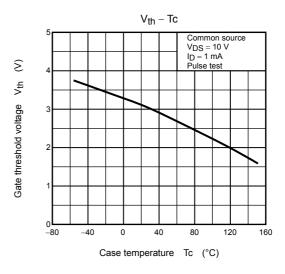


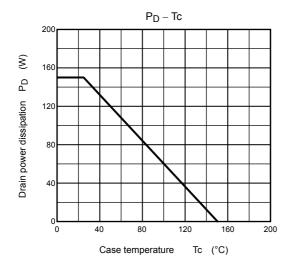


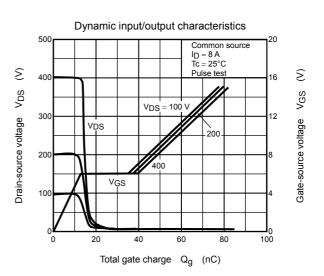


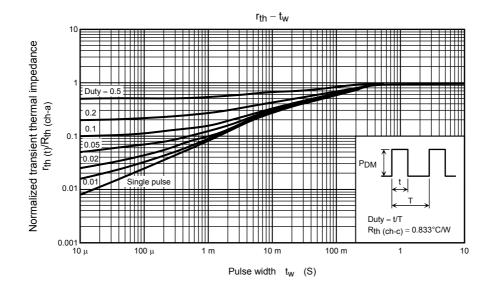


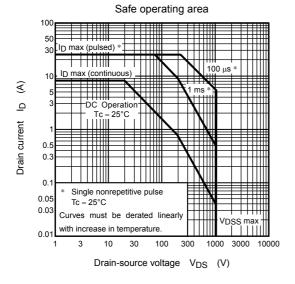


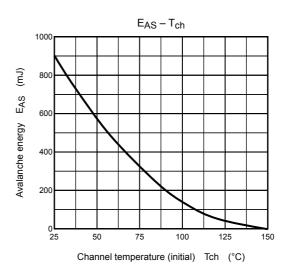


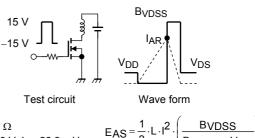












$$\begin{aligned} R_G &= 25~\Omega \\ V_{DD} &= 90~V,~L = 26.3~mH \end{aligned} \qquad E_{AS} &= \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{BVDSS}{BVDSS - VDD} \right) \end{aligned}$$

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